

Search Notes

Application/Control No.

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Sara W. Crane

Applicant(s)/Patent under
Reexamination

TANABE, TAKAHISA

Art Unit

2811

SEARCHED

Class	Subclass	Date	Examiner
257	40	12/05	SWC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR